

New Generation of WICOP

High-Power LED - Z8 Y11

SZ8-Y11-XX-XX-X (Cool, Neutral, Warm)



Product Brief

Description

- The WICOP series is designed for high flux output applications with high current operation capability.
- Compact footprint(1.14x1.14mm) enables system level cost saving
- It incorporates state of the art SMD design and low thermal resistant material.
- The WICOP is ideal light sources for directional lighting applications such as Spot Lights, various outdoor applications, automotive lightings and high performance torches .

Features and Benefits

- Designed for high current operation
- Low Thermal Resistance
- A wide CCT range of 2,600~7,000K
- ANSI compliant Binning
- RoHS compliant
- Phosphor film directly attached to chip surface

Key Applications

- Residential - Replacement lamps
- Commercial/Industrial – Retail Display
- Outdoor area - Flood/Street light, High Bay

Table 1. Product Selection Table

Part Number	CCT			CRI	Voltage
	Color	Min.	Max.	Min	
SZ8-Y11-W0-C7-A/B/C	Cool White	4,700K	7,000K	70	3V/6V/9V
SZ8-Y11-WN-C7-A	Neutral White	3,700K	4,700K	70	3V
SZ8-Y11-W0-C8-A/B/C	Cool White	4,700K	7,000K	80	3V/6V/9V
SZ8-Y11-WN-C8-A/B/C	Neutral White	3,700K	4,700K	80	3V/6V/9V
SZ8-Y11-WW-C8-A/B/C	Warm White	2,600K	3,700K	80	3V/6V/9V
SZ8-Y11-W0-C9-A/B/C	Cool White	4,700K	7,000K	90	3V/6V
SZ8-Y11-WN-C9-A/B/C	Neutral White	3,700K	4,700K	90	3V/6V/9V
SZ8-Y11-WW-C9-A/B/C	Warm White	2,600K	3,700K	90	3V/6V/9V

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Performance Characteristics

Table 2a. Electro Optical Characteristics for SZ8-Y11-XX-XX-A, $I_F=150\text{mA}$

Part Number	Typical Forward Voltage [V _F]	CCT [K] ^[1]		Min. Luminous Flux ^[2] Φ_V ^[3] [lm]		Luminous Flux ^[2] Φ_V ^[3] [lm] @65mA, T _J = 25°C		CRI ^[4] , R _a
		Min.	Max.	Group	T _J =85 °C	Min.	Max.	
SZ8-Y11-W0-C7-A	3V	4700	7000	W4	77	38	40	70
				W3	73	36	38	
				W2	68	34	36	
				W1	64	32	34	
SZ8-Y11-WN-C7-A	3V	3700	4700	W4	77	38	40	70
				W3	73	36	38	
				W2	68	34	36	
				W1	64	32	34	
SZ8-Y11-W0-C8-A	3V	4700	7000	W2	68	34	36	80
				W1	64	32	34	
				V3	60	30	32	
				V2	56	28	30	
SZ8-Y11-WN-C8-A	3V	3700	4700	W2	68	34	36	80
				W1	64	32	34	
				V3	60	30	32	
				V2	56	28	30	
SZ8-Y11-WW-C8-A	3V	2600	3700	W1	64	32	34	80
				V3	60	30	32	
				V2	56	28	30	
				V1	52	26	28	
SZ8-Y11-W0-C9-A	3V	4700	7000	V3	60	30	32	90
				V2	56	28	30	
				V1	52	26	28	
				U3	49	24	26	
SZ8-Y11-WN-C9-A	3V	3700	4700	V3	60	30	32	90
				V2	56	28	30	
				V1	52	26	28	
				U3	49	24	26	
SZ8-Y11-WW-C9-A	3V	2600	3700	V1	52	26	28	90
				U3	49	24	26	
				U2	46	23	24	
				U1	43	21	23	

Notes :

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate : ± 0.005 , CCT $\pm 5\%$ tolerance.

(2) Seoul Semiconductor maintains a tolerance of $\pm 7\%$ on flux and power measurements.

(3) Φ_V is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is ± 2.0 on CRI measurements.

Performance Characteristics

Table 2b. Electro Optical Characteristics for SZ8-Y11-XX-XX-B, $I_F=175mA$

Part Number	Typical Forward Voltage [V _F]	CCT [K] ^[1]		Min. Luminous Flux ^[2] Φ_V ^[3] [lm]		CRI ^[4] , R _a
		Min.	Max.	Group	T _J =85 °C	
SZ8-Y11-W0-C7-B	6V	4700	7000	W4	160	70
				W3	152	
				W2	142	
				W1	133	
SZ8-Y11-W0-C8-B	6V	4700	7000	W2	142	80
				W1	133	
				V3	125	
				V2	116	
SZ8-Y11-WN-C8-B	6V	3700	4700	W2	142	80
				W1	133	
				V3	125	
				V2	116	
SZ8-Y11-WW-C8-B	6V	2600	3700	W1	133	80
				V3	125	
				V2	116	
				V1	109	
SZ8-Y11-W0-C9-B	6V	4700	7000	V3	125	90
				V2	116	
				V1	109	
				U3	102	
SZ8-Y11-WN-C9-B	6V	3700	4700	V3	125	90
				V2	116	
				V1	109	
				U3	102	
SZ8-Y11-WW-C9-B	6V	2600	3700	V1	109	90
				U3	102	
				U2	96	
				U1	89	

Notes :

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate : ± 0.005 , CCT $\pm 5\%$ tolerance.

(2) Seoul Semiconductor maintains a tolerance of $\pm 7\%$ on flux and power measurements.

(3) Φ_V is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is ± 2.0 on CRI measurements.

Performance Characteristics

Table 2c. Electro Optical Characteristics for SZ8-Y11-XX-XX-C, $I_F=115\text{mA}$

Part Number	Typical Forward Voltage [V _F]	CCT [K] ^[1]		Min. Luminous Flux ^[2] Φ_V ^[3] [lm]		CRI ^[4] , R _a
		Min.	Max.	Group	T _J =85 °C	
SZ8-Y11-W0-C7-C	9V	4700	7000	W4	160	70
				W3	152	
				W2	142	
				W1	133	
SZ8-Y11-W0-C8-C	9V	4700	7000	W2	142	80
				W1	133	
				V3	125	
				V2	116	
SZ8-Y11-WN-C8-C	9V	3700	4700	W2	142	80
				W1	133	
				V3	125	
				V2	116	
SZ8-Y11-WW-C8-C	9V	2600	3700	W1	133	80
				V3	125	
				V2	116	
				V1	109	
SZ8-Y11-WN-C9-C	9V	3700	4700	V3	125	90
				V2	116	
				V1	109	
				U3	102	
SZ8-Y11-WW-C9-C	9V	2600	3700	V1	109	90
				U3	102	
				U2	96	
				U1	89	

Notes :

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate : ± 0.005 , CCT $\pm 5\%$ tolerance.

(2) Seoul Semiconductor maintains a tolerance of $\pm 7\%$ on flux and power measurements.

(3) Φ_V is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is ± 2.0 on CRI measurements.

Performance Characteristics

Table 3. Absolute Maximum Ratings

Parameter	Symbol	Value			Unit	
		Min.	Typ.	Max.		
Forward Current ^[1]	Y11-XX-XX-A	I _F	-	150	700	mA
	Y11-XX-XX-B		-	175	350	
	Y11-XX-XX-C		-	115	230	
Power Dissipation	P _D	-	-	2.28	W	
Junction Temperature	T _j	-	-	145	°C	
Operating Temperature	T _{opr}	- 40	-	125	°C	
Storage Temperature	T _{stg}	- 40	-	125	°C	
Viewing angle	θ		150		degree	
Thermal resistance (J to S) ^[2]	Rθ _{J-S}	-	8 ^[3] 10 ^[4]	-	K/W	
ESD Sensitivity(HBM)		Class 2 JESD22-A114-E				

Notes :

(1) At Junction Temperature 85°C condition.

(2) $R\theta_{J-S}$ is tested at typical forward current.

(3) Using Metal PCB (Dielectric layer 5W/m·K and Cu pattern of 2oz).

(4) Using Metal PCB (Normal type).

- Thermal resistance can be increased substantially depending on the heat sink design/operating condition, and the maximum possible driving current will decrease accordingly.

Characteristics Graph

Fig 1. Color Spectrum

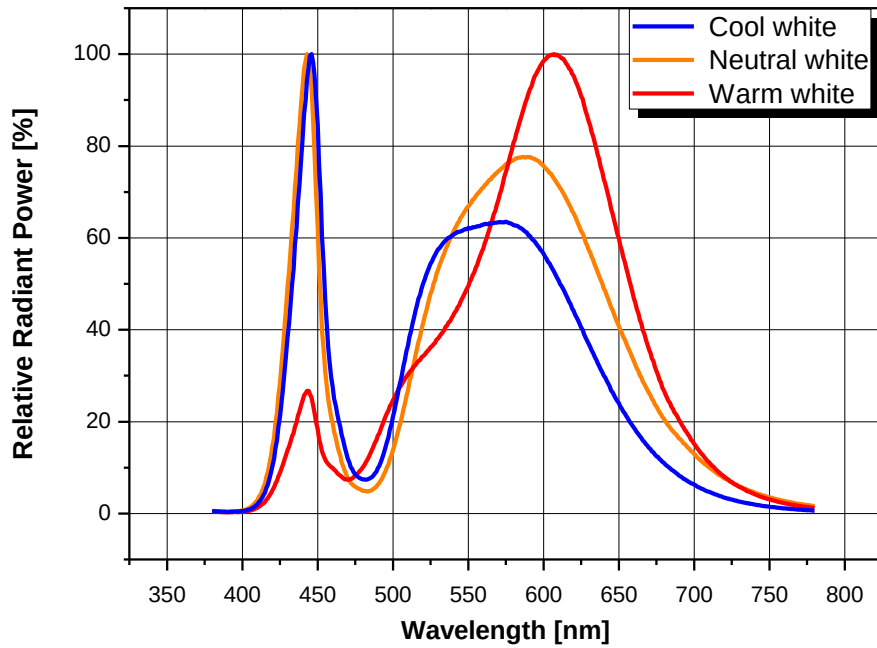
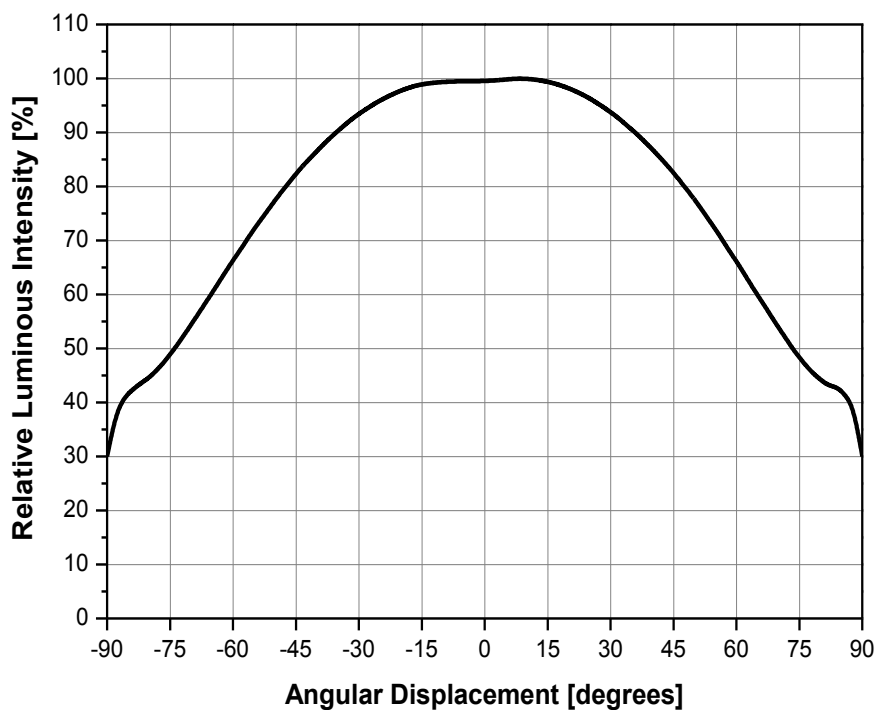


Fig 2. Typical Spatial Distribution



Characteristics Graph

Fig 3a. Forward Voltage vs. Forward Current for Y11-XX-XX-A, $T_j=85^{\circ}\text{C}$

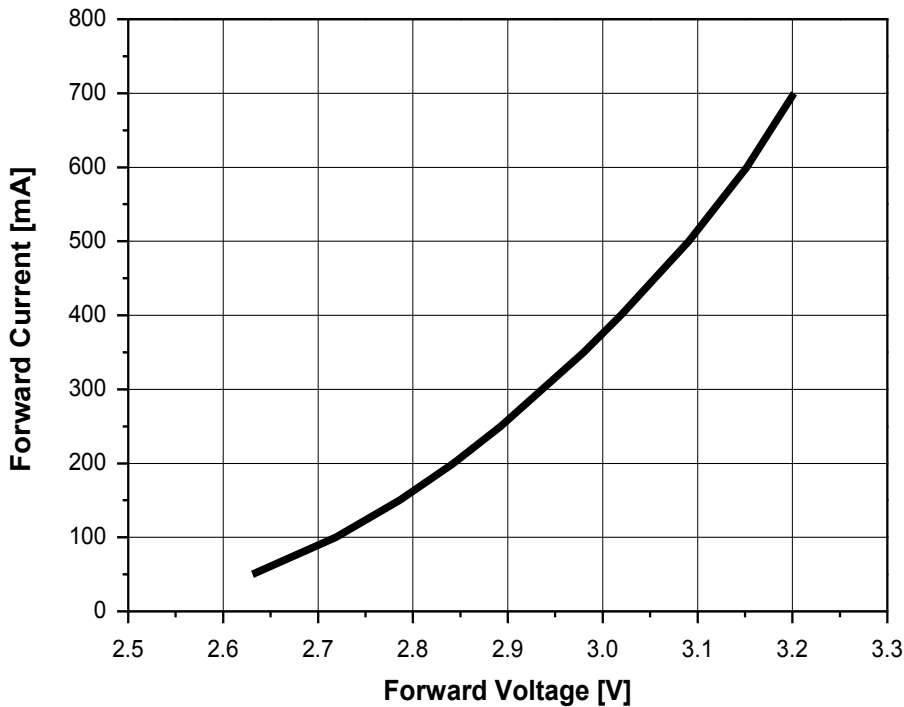
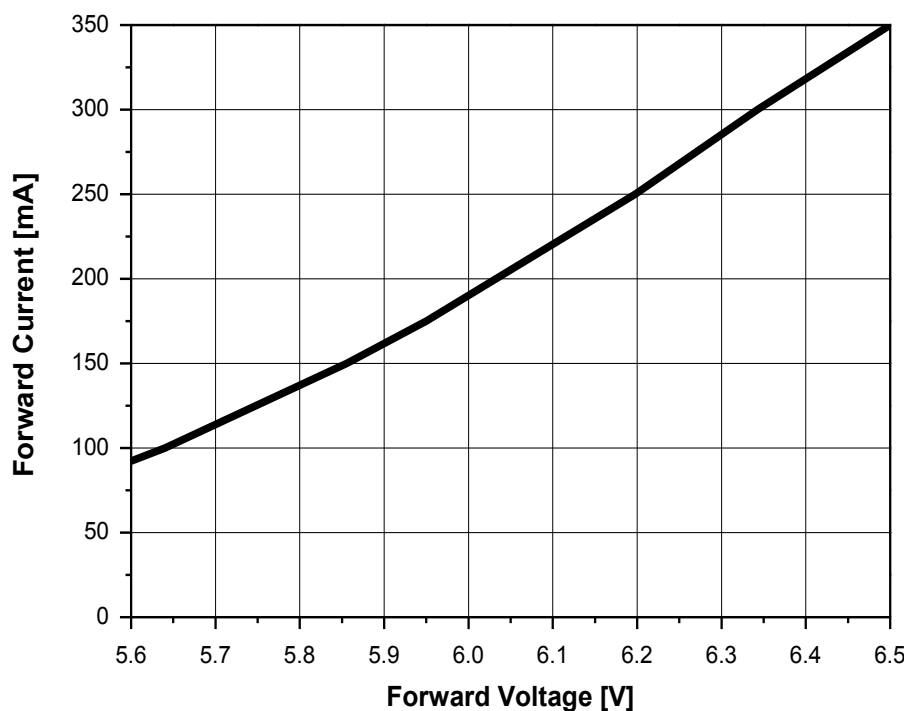
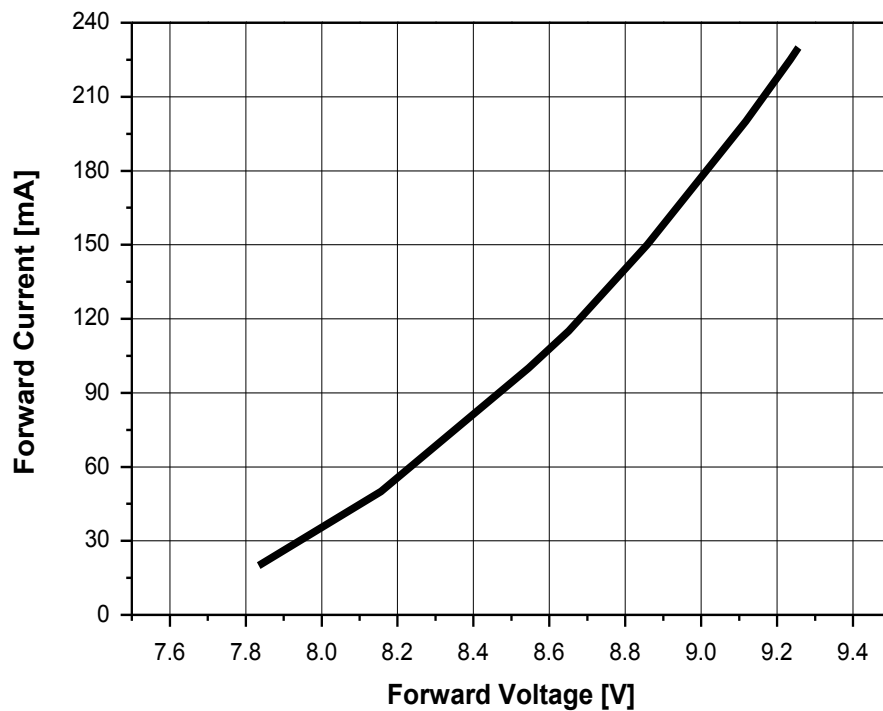


Fig 3b. Forward Voltage vs. Forward Current for Y11-XX-XX-B, $T_j=85^{\circ}\text{C}$



Characteristics Graph

Fig 3c. Forward Voltage vs. Forward Current for Y11-XX-XX-C, $T_j=85^{\circ}\text{C}$



Characteristics Graph

Fig 4a. Forward Current vs. Relative Luminous Flux for Y11-XX-XX-A, $T_j=85^{\circ}\text{C}$

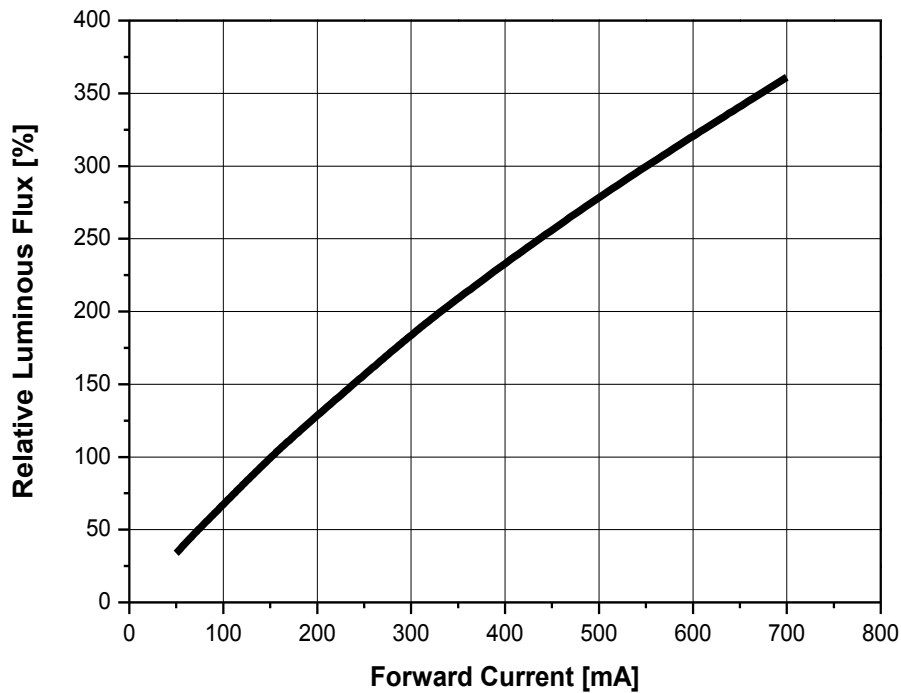
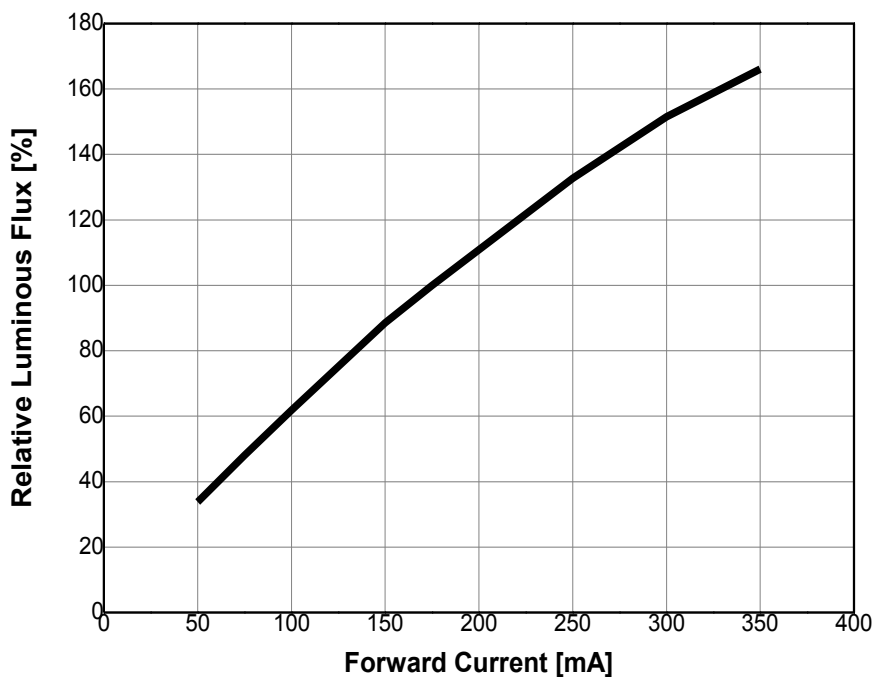
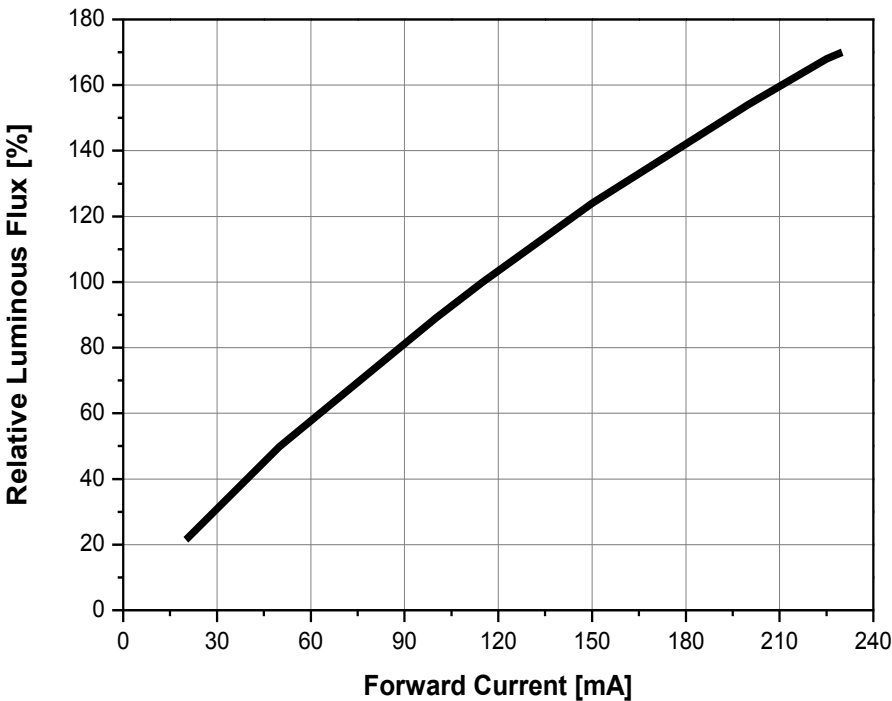


Fig 4b. Forward Current vs. Relative Luminous Flux for Y11-XX-XX-B, $T_j=85^{\circ}\text{C}$



Characteristics Graph

Fig 4c. Forward Current vs. Relative Luminous Flux for Y11-XX-XX-C, $T_j=85^{\circ}\text{C}$



Characteristics Graph

Fig 5. Forward Current vs. CIE X, Y Shift

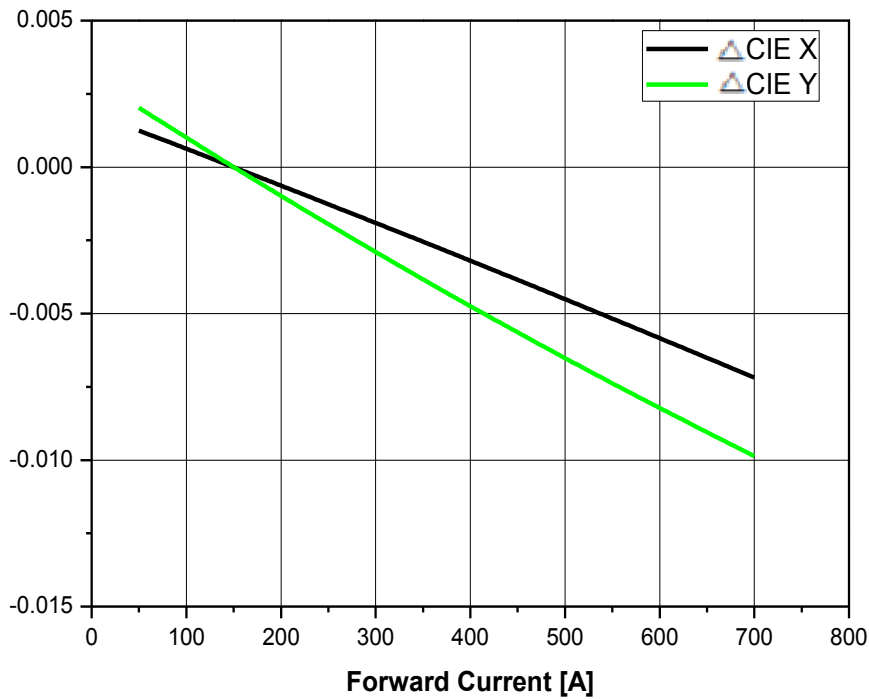
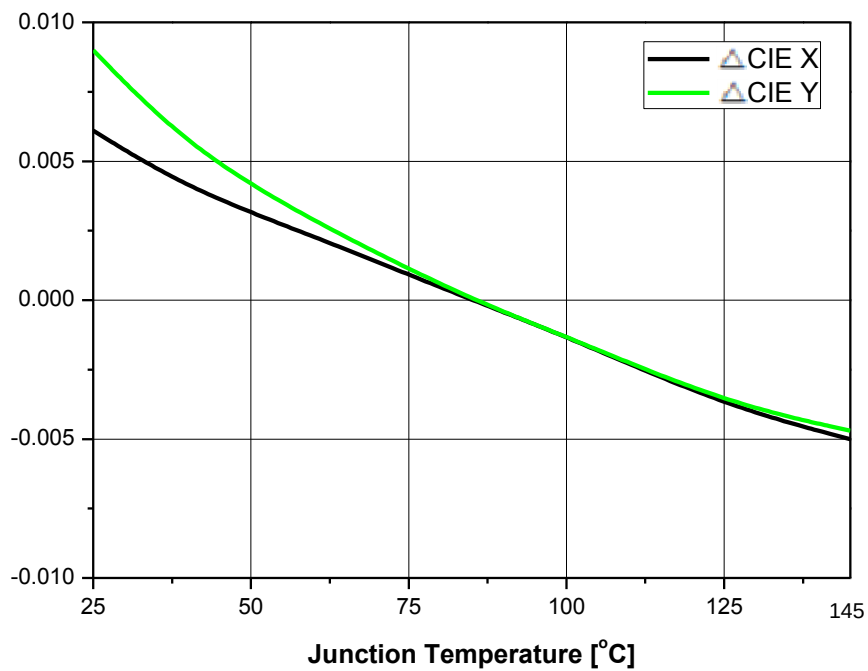


Fig 6. Junction Temp. vs. CIE X, Y Shift



Characteristics Graph

Fig 7a. Relative Light Output vs. Junction Temperature for Y11-XX-XX-A, $I_F=150\text{mA}$

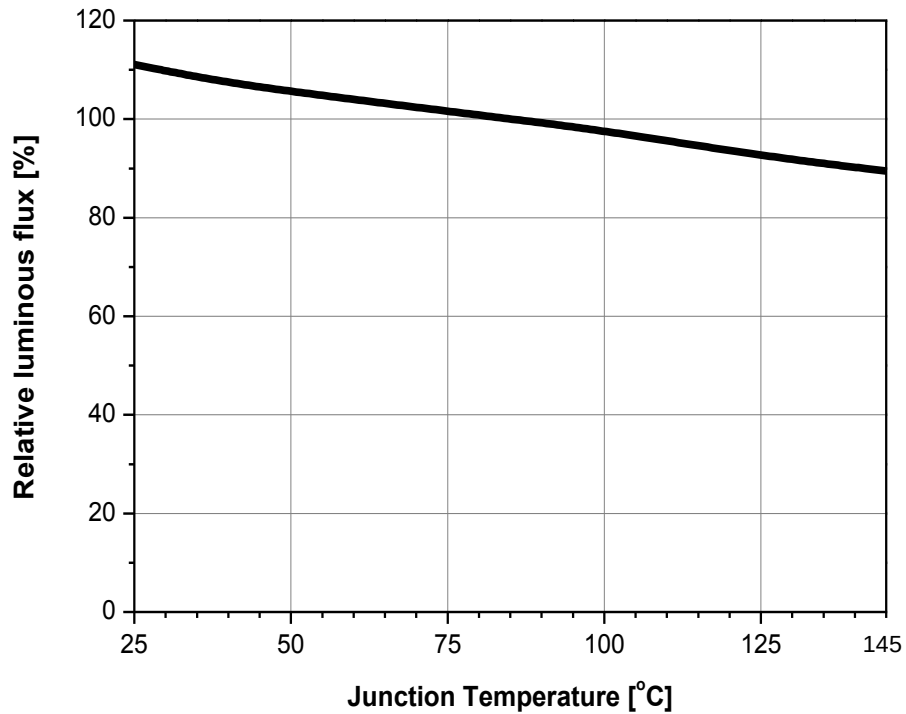
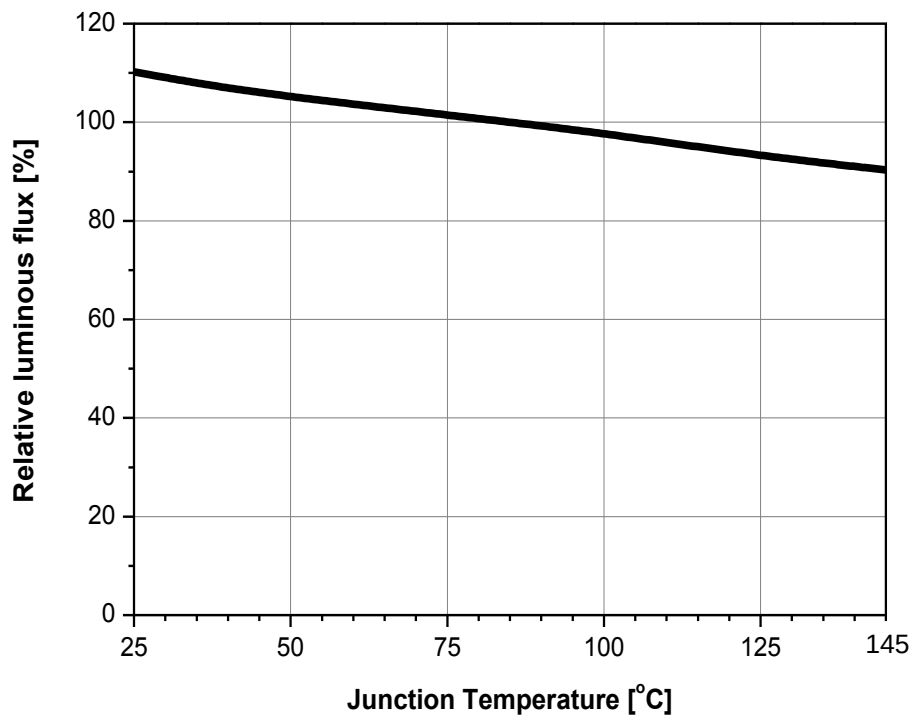
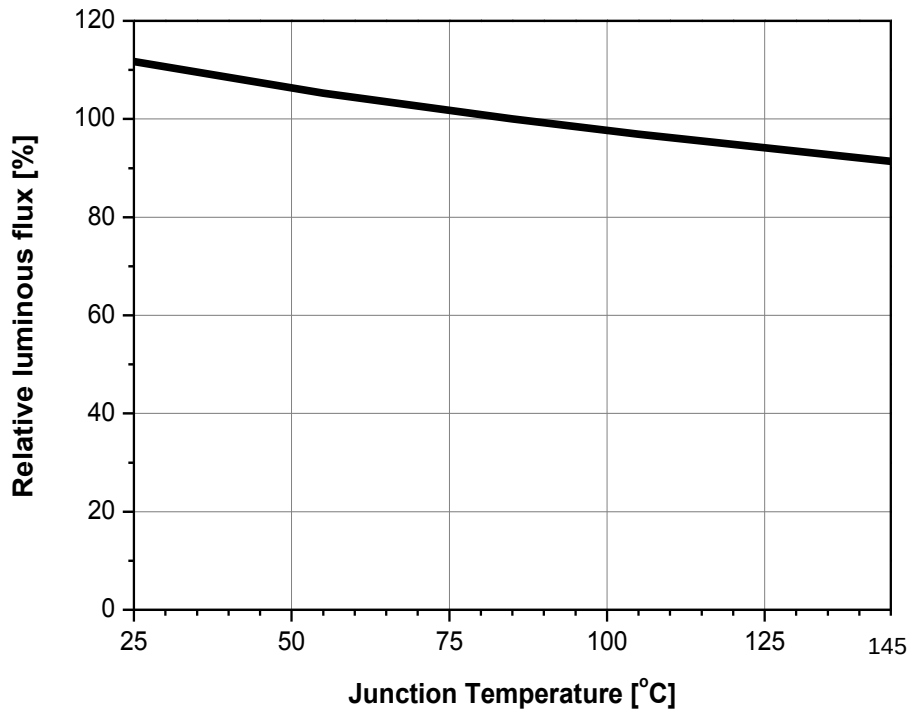


Fig 7b. Relative Forward Voltage vs. Junction Temperature for Y11-XX-XX-B, $I_F=175\text{mA}$



Characteristics Graph

Fig 7c. Relative Light Output vs. Junction Temperature for Y11-XX-XX-C, $I_F=115\text{mA}$



Characteristics Graph

Fig 8a. Relative Forward Voltage vs. Junction Temperature for Y11-XX-XX-A, $I_F=150\text{mA}$

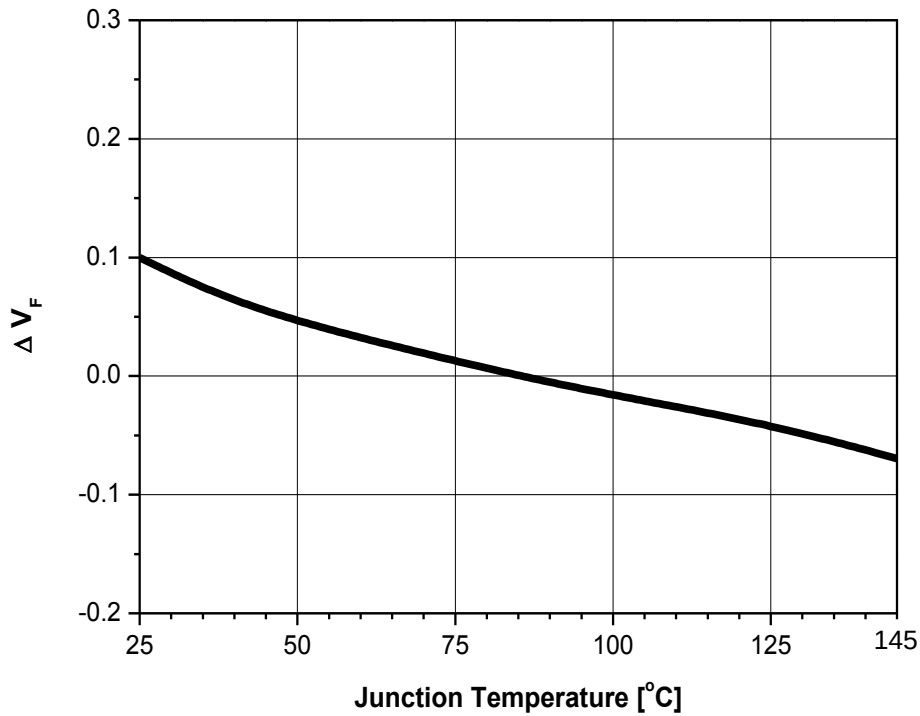
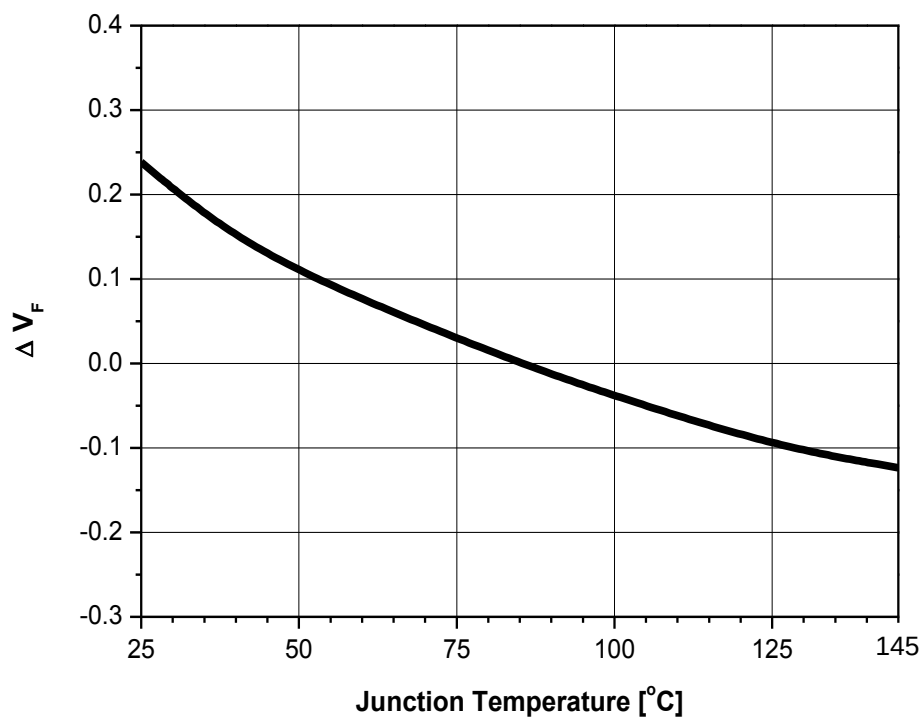
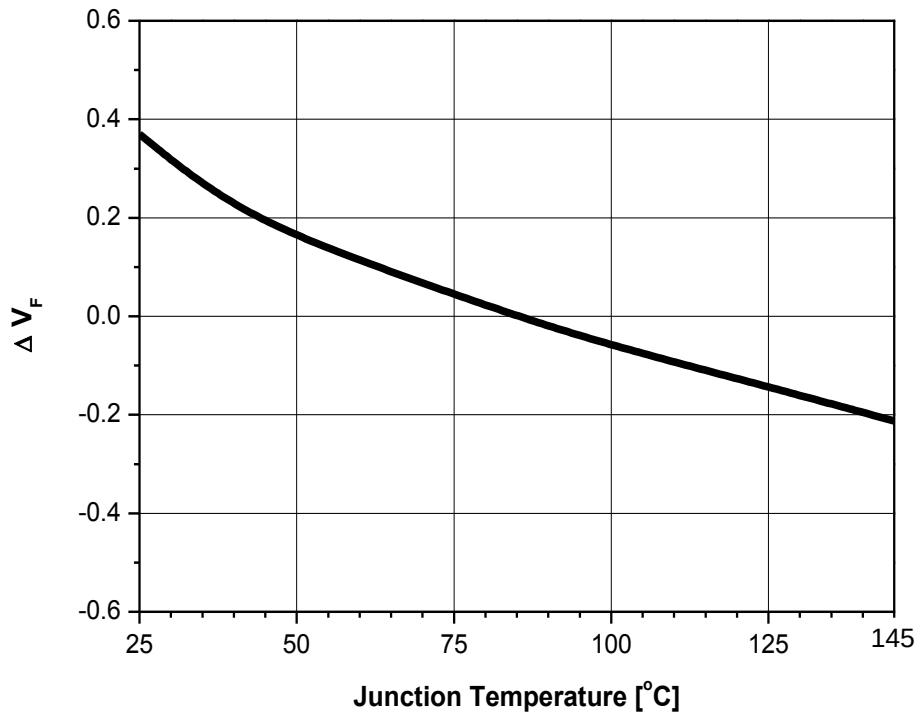


Fig 8b. Relative Forward Voltage vs. Junction Temperature for Y11-XX-XX-B, $I_F=175\text{mA}$



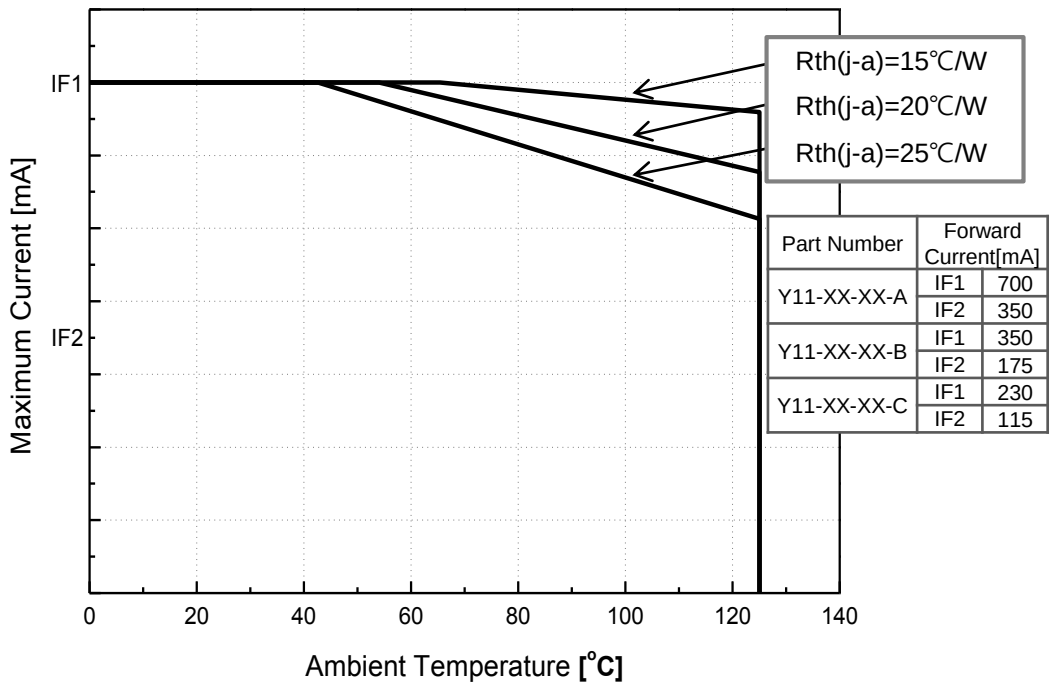
Characteristics Graph

Fig 8c. Relative Light Output vs. Junction Temperature for Y11-XX-XX-C, $I_F=115\text{mA}$



Characteristics Graph

Fig 9. Maximum Forward Current vs. Ambient Temperature, $T_j(max.)=145^{\circ}C$



Performance Characteristics

Table 4. Bin Code description, $I_F=150\text{mA}$, $T_J=85^\circ\text{C}$ (CRI70)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C7-A	W4	77	80	Refer to page. 27~29	G	2.55	2.80
	W3	73	77				
	W2	68	73		H	2.80	3.05
	W1	64	68				
SZ8-Y11-WN-C7-A	W4	77	80	Refer to page. 30~31	G	2.55	2.80
	W3	73	77				
	W2	68	73		H	2.80	3.05
	W1	64	68				

Table 5. Luminous Flux rank distribution (CRI70)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	V2	V3	W1	W2	W3	W4
5,300 ~ 6,000K	B	V2	V3	W1	W2	W3	W4
4,700 ~ 5,300K	C	V2	V3	W1	W2	W3	W4
4,200 ~ 4,700K	D	V2	V3	W1	W2	W3	W4
3,700 ~ 4,200K	E	V2	V3	W1	W2	W3	W4

Notes :

- (1) Tolerance is $\pm 0.06\text{V}$ on forward voltage measurements.
- (2) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=150\text{mA}$, $T_J=85^\circ\text{C}$ (CRI80)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C8-A	W2	68	73	Refer to page. 27~29	G	2.55	2.80
	W1	64	68				
	V3	60	64		H	2.80	3.05
	V2	56	60				
SZ8-Y11-WN-C8-A	W2	68	73	Refer to page. 30~31	G	2.55	2.80
	W1	64	68				
	V3	60	64		H	2.80	3.05
	V2	56	60				
SZ8-Y11-WW-C8-A	W1	64	68	Refer to page. 32~34	G	2.55	2.80
	V3	60	64				
	V2	56	60		H	2.80	3.05
	V1	52	56				

Table 5. Luminous Flux rank distribution (CRI80)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	V1	V2	V3	W1	W2	W3
5,300 ~ 6,000K	B	V1	V2	V3	W1	W2	W3
4,700 ~ 5,300K	C	V1	V2	V3	W1	W2	W3
4,200 ~ 4,700K	D	V1	V2	V3	W1	W2	W3
3,700 ~ 4,200K	E	V1	V2	V3	W1	W2	W3
3,200 ~ 3,700K	F	V1	V2	V3	W1	W2	W3
2,900 ~ 3,200K	G	V1	V2	V3	W1	W2	W3
2,600 ~ 2,900K	H	V1	V2	V3	W1	W2	W3

Notes :

- (1) Tolerance is $\pm 0.06\text{V}$ on forward voltage measurements.
- (2) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=150\text{mA}$, $T_J=85^\circ\text{C}$ (CRI90)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C9-A	V3	60	64	Refer to page. 27~29	G	2.55	2.80
	V2	56	60				
	V1	52	56		H	2.80	3.05
	U3	49	52				
SZ8-Y11-WN-C9-A	V3	60	64	Refer to page. 30~31	G	2.55	2.80
	V2	56	60				
	V1	52	56		H	2.80	3.05
	U3	49	52				
SZ8-Y11-WW-C9-A	V1	52	56	Refer to page. 32~34	G	2.55	2.80
	U3	49	52				
	U2	46	49		H	2.80	3.05
	U1	43	46				

Table 5. Luminous Flux rank distribution (CRI90)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	U1	U2	U3	V1	V2	V3
5,300 ~ 6,000K	B	U1	U2	U3	V1	V2	V3
4,700 ~ 5,300K	C	U1	U2	U3	V1	V2	V3
4,200 ~ 4,700K	D	U1	U2	U3	V1	V2	V3
3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3
3,200 ~ 3,700K	F	U1	U2	U3	V1	V2	V3
2,900 ~ 3,200K	G	U1	U2	U3	V1	V2	V3
2,600 ~ 2,900K	H	U1	U2	U3	V1	V2	V3

Notes :

- (1) Tolerance is $\pm 0.06\text{V}$ on forward voltage measurements.
- (2) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=175\text{mA}$, $T_J=85^\circ\text{C}$ (CRI80)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C8-B	W2	142	152	Refer to page. 27~29	H	5.60	5.90
	W1	133	142				
	V3	125	133		I	5.90	6.20
	V2	116	125				
SZ8-Y11-WN-C8-B	W2	142	152	Refer to page. 30~31	H	5.60	5.90
	W1	133	142				
	V3	125	133		I	5.90	6.20
	V2	116	125				
SZ8-Y11-WW-C8-B	W1	133	142	Refer to page. 32~34	H	5.60	5.90
	V3	125	133				
	V2	116	125		I	5.90	6.20
	V1	109	116				

Table 5. Luminous Flux rank distribution (CRI80)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	V1	V2	V3	W1	W2	W3
5,300 ~ 6,000K	B	V1	V2	V3	W1	W2	W3
4,700 ~ 5,300K	C	V1	V2	V3	W1	W2	W3
4,200 ~ 4,700K	D	V1	V2	V3	W1	W2	W3
3,700 ~ 4,200K	E	V1	V2	V3	W1	W2	W3
3,200 ~ 3,700K	F	V1	V2	V3	W1	W2	W3
2,900 ~ 3,200K	G	V1	V2	V3	W1	W2	W3
2,600 ~ 2,900K	H	V1	V2	V3	W1	W2	W3

Notes :

- (1) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=175\text{mA}$, $T_J=85^\circ\text{C}$ (CRI90)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C9-B	V3	125	133	Refer to page. 27~29	H	5.60	5.90
	V2	116	125		I	5.90	6.20
	V1	109	116				
	U3	102	109				
SZ8-Y11-WN-C9-B	V3	125	133	Refer to page. 30~31	H	5.60	5.90
	V2	116	125		I	5.90	6.20
	V1	109	116				
	U3	102	109				
SZ8-Y11-WW-C9-B	V1	109	116	Refer to page. 32~34	H	5.60	5.90
	U3	102	109		I	5.90	6.20
	U2	96	102				
	U1	89	96				

Table 5. Luminous Flux rank distribution (CRI90)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	U1	U2	U3	V1	V2	V3
5,300 ~ 6,000K	B	U1	U2	U3	V1	V2	V3
4,700 ~ 5,300K	C	U1	U2	U3	V1	V2	V3
4,200 ~ 4,700K	D	U1	U2	U3	V1	V2	V3
3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3
3,200 ~ 3,700K	F	U1	U2	U3	V1	V2	V3
2,900 ~ 3,200K	G	U1	U2	U3	V1	V2	V3
2,600 ~ 2,900K	H	U1	U2	U3	V1	V2	V3

Notes :

- (1) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=115\text{mA}$, $T_J=85^\circ\text{C}$ (CRI70)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C7-C	W4	160	167	Refer to page. 27~29	H	8.50	8.80
	W3	152	160				
	W2	142	152		I	8.80	9.15
	W1	133	142				

Table 5. Luminous Flux rank distribution (CRI70)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	V2	V3	W1	W2	W3	W4
5,300 ~ 6,000K	B	V2	V3	W1	W2	W3	W4
4,700 ~ 5,300K	C	V2	V3	W1	W2	W3	W4

Notes :

- (1) Tolerance is $\pm 0.06\text{V}$ on forward voltage measurements.
- (2) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=115\text{mA}$, $T_J=85^\circ\text{C}$ (CRI80)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-W0-C8-C	W2	142	152	Refer to page. 27~29	H	8.50	8.80
	W1	133	142				
	V3	125	133		I	8.80	9.15
	V2	116	125				
SZ8-Y11-WN-C8-C	W2	142	152	Refer to page. 30~31	H	8.50	8.80
	W1	133	142				
	V3	125	133		I	8.80	9.15
	V2	116	125				
SZ8-Y11-WW-C8-C	W1	133	142	Refer to page. 32~34	H	8.50	8.80
	V3	125	133				
	V2	116	125		I	8.80	9.15
	V1	109	116				

Table 5. Luminous Flux rank distribution (CRI80)
 Available Rank

CCT	CIE	Luminous Flux Rank					
6,000 ~ 7,000K	A	V1	V2	V3	W1	W2	W3
5,300 ~ 6,000K	B	V1	V2	V3	W1	W2	W3
4,700 ~ 5,300K	C	V1	V2	V3	W1	W2	W3
4,200 ~ 4,700K	D	V1	V2	V3	W1	W2	W3
3,700 ~ 4,200K	E	V1	V2	V3	W1	W2	W3
3,200 ~ 3,700K	F	V1	V2	V3	W1	W2	W3
2,900 ~ 3,200K	G	V1	V2	V3	W1	W2	W3
2,600 ~ 2,900K	H	V1	V2	V3	W1	W2	W3

Notes :

- (1) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Performance Characteristics

Table 4. Bin Code description, $I_F=115\text{mA}$, $T_J=85^\circ\text{C}$ (CRI90)

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [V_F] ^[1] *		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
SZ8-Y11-WN-C9-C	V3	125	133	Refer to page. 30~31	H	8.50	8.80
	V2	116	125				
	V1	109	116		I	8.80	9.15
	U3	102	109				
SZ8-Y11-WW-C9-C	V1	109	116	Refer to page. 32~34	H	8.50	8.80
	U3	102	109				
	U2	96	102		I	8.80	9.15
	U1	89	96				

Table 5. Luminous Flux rank distribution (CRI90)
 Available Rank

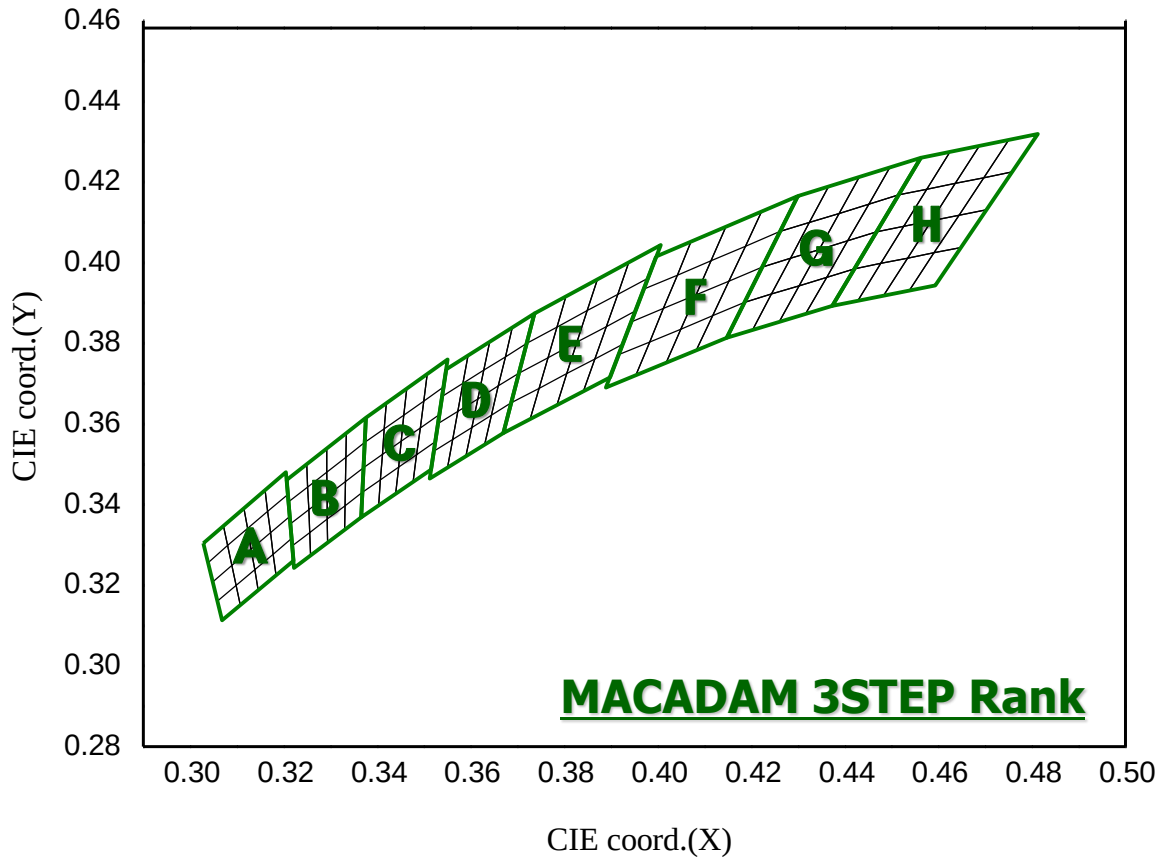
CCT	CIE	Luminous Flux Rank					
4,200 ~ 4,700K	D	U1	U2	U3	V1	V2	V3
3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3
3,200 ~ 3,700K	F	U1	U2	U3	V1	V2	V3
2,900 ~ 3,200K	G	U1	U2	U3	V1	V2	V3
2,600 ~ 2,900K	H	U1	U2	U3	V1	V2	V3

Notes :

- (1) All measurements were made under the standardized environment of Seoul Semiconductor
In order to ensure availability, single color rank will not be orderable.

Color Bin Structure

CIE Chromaticity Diagram (Cool White), $T_j=85^{\circ}\text{C}$

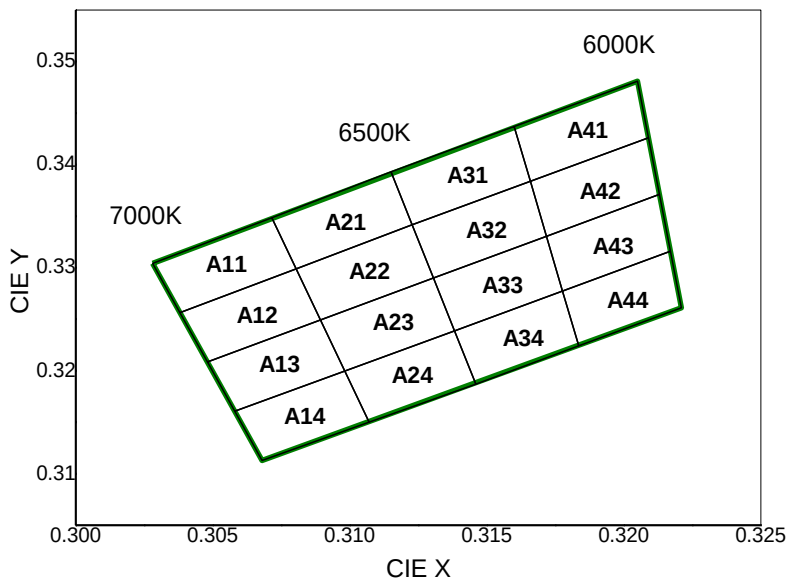


***Notes :**

- Energy Star binning applied to all 2600~7000K.
- Measurement Uncertainty of the Color Coordinates : ± 0.005

Color Bin Structure

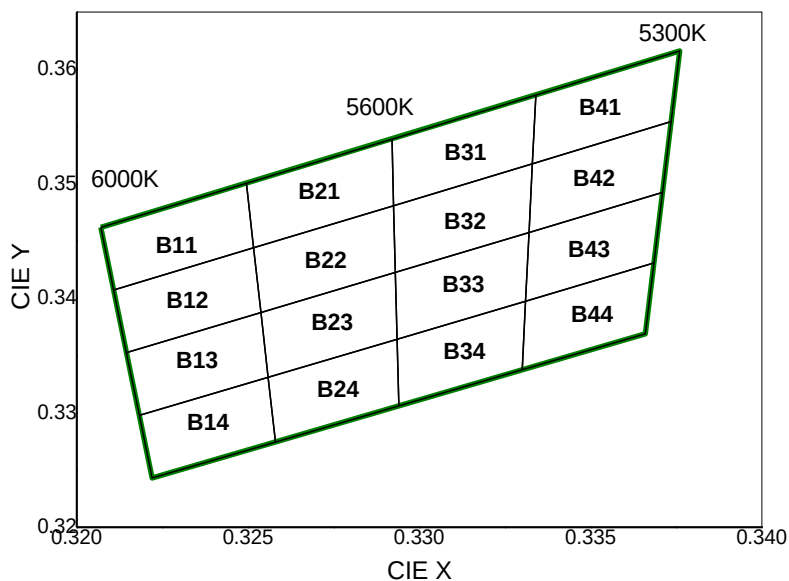
CIE Chromaticity Diagram (Cool White), $T_j=85^{\circ}\text{C}$



A11		A21		A31		A41	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3028	0.3304	0.3072	0.3349	0.3115	0.3393	0.3160	0.3437
0.3038	0.3256	0.3080	0.3299	0.3123	0.3342	0.3166	0.3384
0.3080	0.3299	0.3123	0.3342	0.3166	0.3384	0.3209	0.3426
0.3072	0.3349	0.3115	0.3393	0.3160	0.3437	0.3205	0.3481
A12		A22		A32		A42	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3038	0.3256	0.3080	0.3299	0.3123	0.3342	0.3166	0.3384
0.3048	0.3209	0.3089	0.3249	0.3131	0.3290	0.3172	0.3331
0.3089	0.3249	0.3131	0.3290	0.3172	0.3331	0.3213	0.3371
0.3080	0.3299	0.3123	0.3342	0.3166	0.3384	0.3209	0.3426
A13		A23		A33		A43	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3048	0.3209	0.3089	0.3249	0.3131	0.3290	0.3172	0.3331
0.3058	0.3161	0.3098	0.3200	0.3138	0.3239	0.3178	0.3277
0.3098	0.3200	0.3138	0.3239	0.3178	0.3277	0.3217	0.3316
0.3089	0.3249	0.3131	0.3290	0.3172	0.3331	0.3213	0.3371
A14		A24		A34		A44	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3058	0.3161	0.3098	0.3200	0.3138	0.3239	0.3178	0.3277
0.3068	0.3113	0.3107	0.3150	0.3146	0.3187	0.3184	0.3224
0.3107	0.3150	0.3146	0.3187	0.3184	0.3224	0.3221	0.3261
0.3098	0.3200	0.3138	0.3239	0.3178	0.3277	0.3217	0.3316

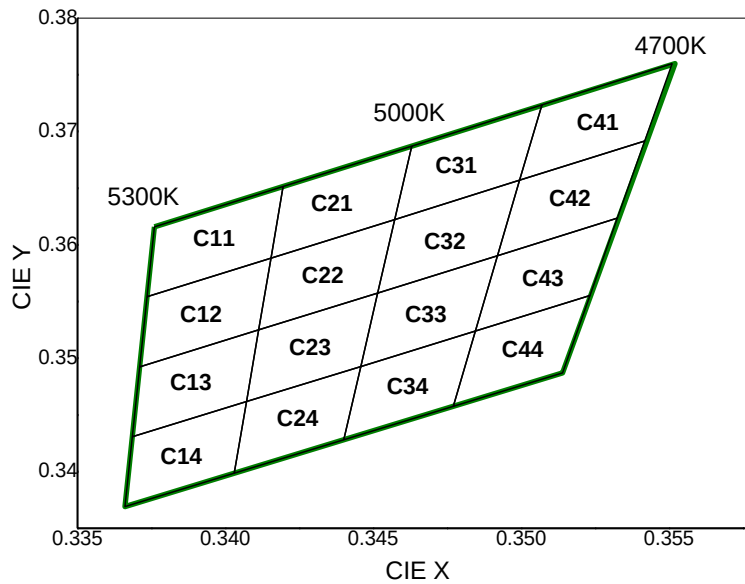
Color Bin Structure

CIE Chromaticity Diagram (Cool White), $T_j=85^{\circ}\text{C}$



B11		B21		B31		B41	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3207	0.3462	0.3250	0.3501	0.3292	0.3539	0.3334	0.3578
0.3211	0.3407	0.3252	0.3444	0.3293	0.3481	0.3333	0.3518
0.3252	0.3444	0.3293	0.3481	0.3333	0.3518	0.3374	0.3554
0.3250	0.3501	0.3292	0.3539	0.3334	0.3578	0.3376	0.3616
B12		B22		B32		B42	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3211	0.3407	0.3252	0.3444	0.3293	0.3481	0.3333	0.3518
0.3215	0.3353	0.3254	0.3388	0.3293	0.3423	0.3332	0.3458
0.3254	0.3388	0.3293	0.3423	0.3332	0.3458	0.3371	0.3493
0.3252	0.3444	0.3293	0.3481	0.3333	0.3518	0.3374	0.3554
B13		B23		B33		B43	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3215	0.3353	0.3254	0.3388	0.3293	0.3423	0.3332	0.3458
0.3218	0.3298	0.3256	0.3331	0.3294	0.3364	0.3331	0.3398
0.3256	0.3331	0.3294	0.3364	0.3331	0.3398	0.3369	0.3431
0.3254	0.3388	0.3293	0.3423	0.3332	0.3458	0.3371	0.3493
B14		B24		B34		B44	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3218	0.3298	0.3256	0.3331	0.3294	0.3364	0.3331	0.3398
0.3222	0.3243	0.3258	0.3275	0.3294	0.3306	0.3330	0.3338
0.3258	0.3275	0.3294	0.3306	0.3330	0.3338	0.3366	0.3369
0.3256	0.3331	0.3294	0.3364	0.3331	0.3398	0.3369	0.3431

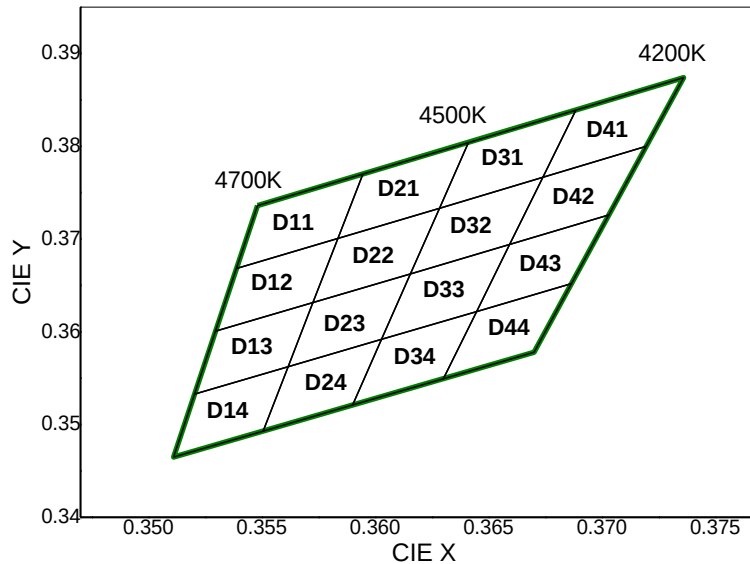
Color Bin Structure

CIE Chromaticity Diagram (Cool White), $T_j=85^{\circ}\text{C}$


C11		C21		C31		C41	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3376	0.3616	0.3420	0.3652	0.3463	0.3687	0.3507	0.3724
0.3374	0.3554	0.3415	0.3588	0.3457	0.3622	0.3500	0.3657
0.3415	0.3588	0.3457	0.3622	0.3500	0.3657	0.3542	0.3692
0.3420	0.3652	0.3463	0.3687	0.3507	0.3724	0.3551	0.3760
C12		C22		C32		C42	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3374	0.3554	0.3415	0.3588	0.3457	0.3622	0.3500	0.3657
0.3371	0.3493	0.3411	0.3525	0.3452	0.3558	0.3492	0.3591
0.3411	0.3525	0.3452	0.3558	0.3492	0.3591	0.3533	0.3624
0.3415	0.3588	0.3457	0.3622	0.3500	0.3657	0.3542	0.3692
C13		C23		C33		C43	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3371	0.3493	0.3411	0.3525	0.3452	0.3558	0.3492	0.3591
0.3369	0.3431	0.3407	0.3462	0.3446	0.3493	0.3485	0.3524
0.3407	0.3462	0.3446	0.3493	0.3485	0.3524	0.3523	0.3555
0.3411	0.3525	0.3452	0.3558	0.3492	0.3591	0.3533	0.3624
C14		C24		C34		C44	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3369	0.3431	0.3407	0.3462	0.3446	0.3493	0.3485	0.3524
0.3366	0.3369	0.3403	0.3399	0.3440	0.3428	0.3477	0.3458
0.3403	0.3399	0.3440	0.3428	0.3477	0.3458	0.3514	0.3487
0.3407	0.3462	0.3446	0.3493	0.3485	0.3524	0.3523	0.3555

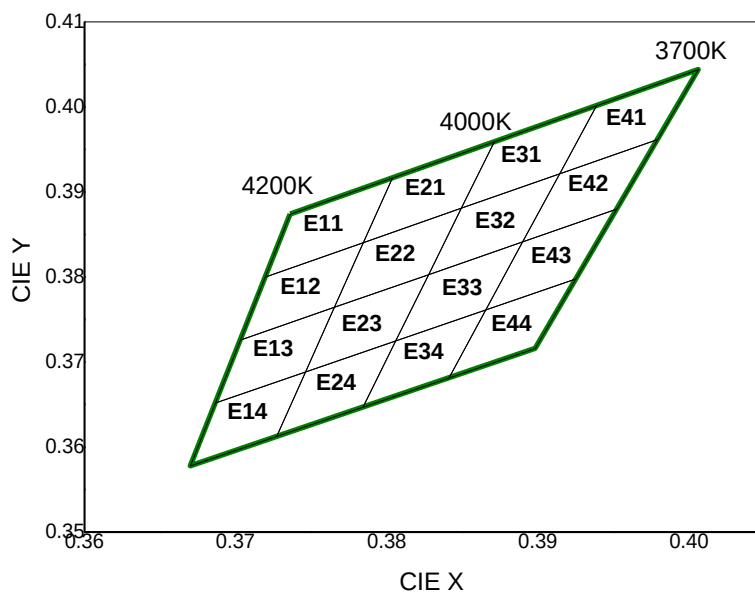
Color Bin Structure

CIE Chromaticity Diagram (Neutral White), $T_j=85^{\circ}\text{C}$



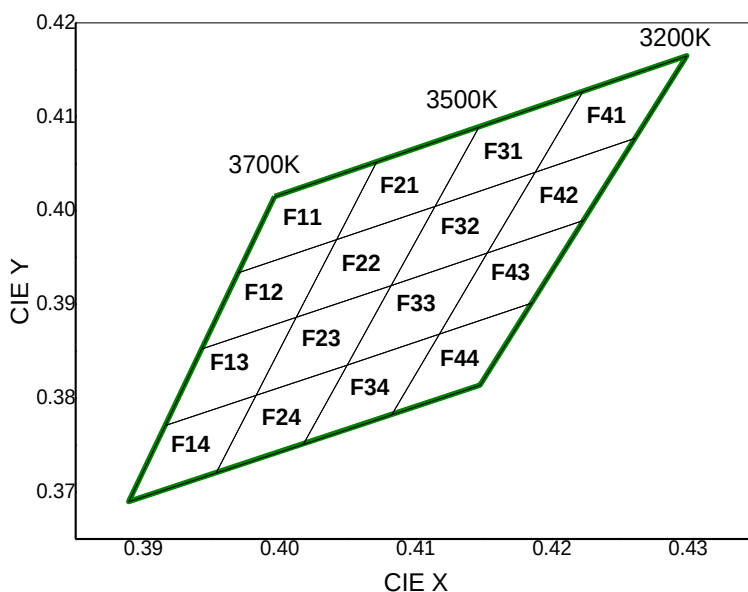
D11		D21		D31		D41	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3548	0.3736	0.3595	0.3770	0.3641	0.3804	0.3689	0.3839
0.3539	0.3668	0.3584	0.3701	0.3628	0.3733	0.3674	0.3767
0.3584	0.3701	0.3628	0.3733	0.3674	0.3767	0.3720	0.3800
0.3595	0.3770	0.3641	0.3804	0.3689	0.3839	0.3736	0.3874
D12		D22		D32		D42	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3539	0.3668	0.3584	0.3701	0.3628	0.3733	0.3674	0.3767
0.3530	0.3601	0.3573	0.3632	0.3616	0.3663	0.3659	0.3694
0.3573	0.3632	0.3616	0.3663	0.3659	0.3694	0.3703	0.3726
0.3584	0.3701	0.3628	0.3733	0.3674	0.3767	0.3720	0.3800
D13		D23		D33		D43	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3530	0.3601	0.3573	0.3632	0.3616	0.3663	0.3659	0.3694
0.3520	0.3533	0.3562	0.3562	0.3603	0.3592	0.3645	0.3622
0.3562	0.3562	0.3603	0.3592	0.3645	0.3622	0.3687	0.3652
0.3573	0.3632	0.3616	0.3663	0.3659	0.3694	0.3703	0.3726
D14		D24		D34		D44	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3520	0.3533	0.3562	0.3562	0.3603	0.3592	0.3645	0.3622
0.3511	0.3465	0.3551	0.3493	0.3590	0.3521	0.3630	0.3550
0.3551	0.3493	0.3590	0.3521	0.3630	0.3550	0.3670	0.3578
0.3562	0.3562	0.3603	0.3592	0.3645	0.3622	0.3687	0.3652

Color Bin Structure

CIE Chromaticity Diagram (Neutral White), $T_j=85^{\circ}\text{C}$


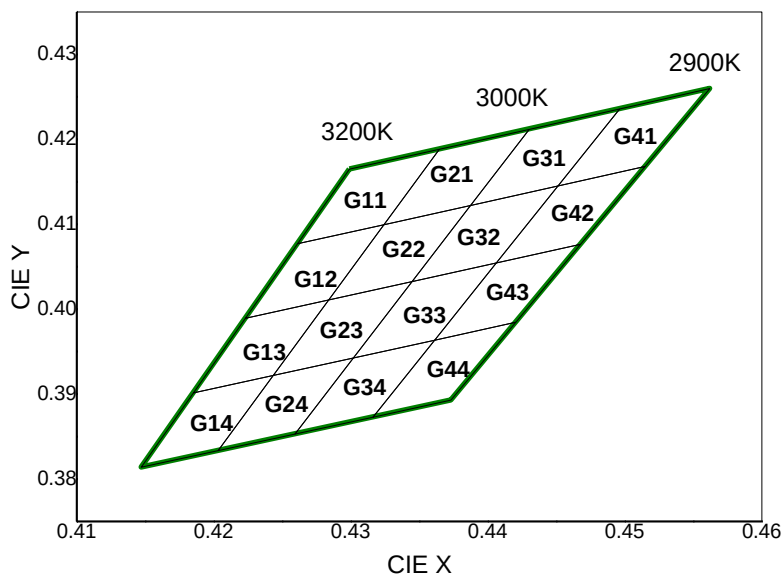
E11		E21		E31		E41	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3736	0.3874	0.3804	0.3917	0.3871	0.3959	0.3939	0.4002
0.3720	0.3800	0.3784	0.3841	0.3849	0.3881	0.3914	0.3922
0.3784	0.3841	0.3849	0.3881	0.3914	0.3922	0.3979	0.3962
0.3804	0.3917	0.3871	0.3959	0.3939	0.4002	0.4006	0.4044
E12		E22		E32		E42	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3720	0.3800	0.3784	0.3841	0.3849	0.3881	0.3914	0.3922
0.3703	0.3726	0.3765	0.3765	0.3828	0.3803	0.3890	0.3842
0.3765	0.3765	0.3828	0.3803	0.3890	0.3842	0.3952	0.3880
0.3784	0.3841	0.3849	0.3881	0.3914	0.3922	0.3979	0.3962
E13		E23		E33		E43	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3703	0.3726	0.3765	0.3765	0.3828	0.3803	0.3890	0.3842
0.3687	0.3652	0.3746	0.3689	0.3806	0.3725	0.3865	0.3762
0.3746	0.3689	0.3806	0.3725	0.3865	0.3762	0.3925	0.3798
0.3765	0.3765	0.3828	0.3803	0.3890	0.3842	0.3952	0.3880
E14		E24		E34		E44	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3687	0.3652	0.3746	0.3689	0.3806	0.3725	0.3865	0.3762
0.3670	0.3578	0.3727	0.3613	0.3784	0.3647	0.3841	0.3682
0.3727	0.3613	0.3784	0.3647	0.3841	0.3682	0.3898	0.3716
0.3746	0.3689	0.3806	0.3725	0.3865	0.3762	0.3925	0.3798

Color Bin Structure

CIE Chromaticity Diagram (Warm White), $T_j=85^{\circ}\text{C}$


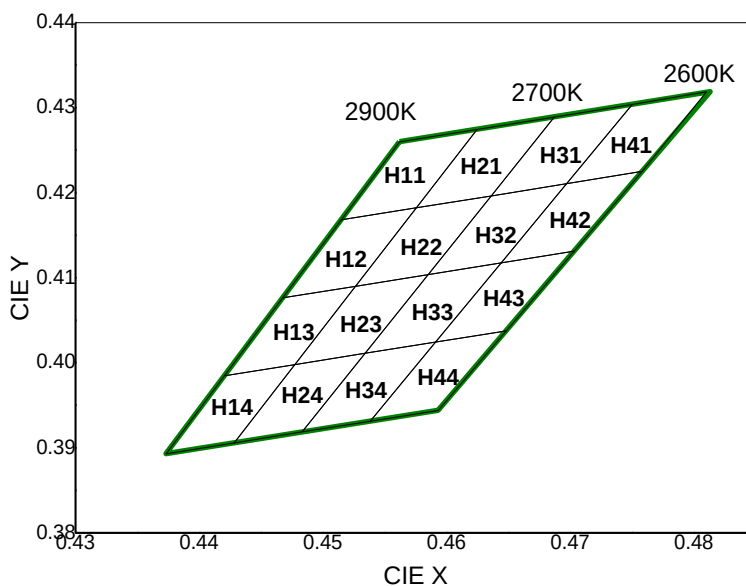
F11		F21		F31		F41	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3996	0.4015	0.4071	0.4052	0.4146	0.4089	0.4223	0.4127
0.3969	0.3934	0.4042	0.3969	0.4114	0.4005	0.4187	0.4041
0.4042	0.3969	0.4114	0.4005	0.4187	0.4041	0.4261	0.4077
0.4071	0.4052	0.4146	0.4089	0.4223	0.4127	0.4299	0.4165
F12		F22		F32		F42	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3969	0.3934	0.4042	0.3969	0.4114	0.4005	0.4187	0.4041
0.3943	0.3853	0.4012	0.3886	0.4082	0.3920	0.4152	0.3955
0.4012	0.3886	0.4082	0.3920	0.4152	0.3955	0.4223	0.3990
0.4042	0.3969	0.4114	0.4005	0.4187	0.4041	0.4261	0.4077
F13		F23		F33		F43	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3943	0.3853	0.4012	0.3886	0.4082	0.3920	0.4152	0.3955
0.3916	0.3771	0.3983	0.3803	0.4049	0.3836	0.4117	0.3869
0.3983	0.3803	0.4049	0.3836	0.4117	0.3869	0.4185	0.3902
0.4012	0.3886	0.4082	0.3920	0.4152	0.3955	0.4223	0.3990
F14		F24		F34		F44	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.3916	0.3771	0.3983	0.3803	0.4049	0.3836	0.4117	0.3869
0.3889	0.3690	0.3953	0.3721	0.4017	0.3751	0.4082	0.3783
0.3953	0.3721	0.4017	0.3751	0.4082	0.3783	0.4147	0.3814
0.3983	0.3803	0.4049	0.3836	0.4117	0.3869	0.4185	0.3902

Color Bin Structure

CIE Chromaticity Diagram (Warm White), $T_j=85^{\circ}\text{C}$


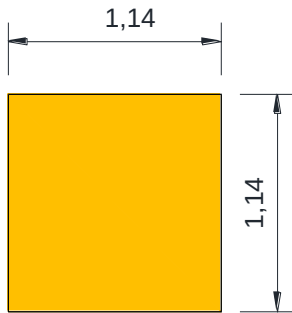
G11		G21		G31		G41	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4299	0.4165	0.4364	0.4188	0.4430	0.4212	0.4496	0.4236
0.4261	0.4077	0.4324	0.4099	0.4387	0.4122	0.4451	0.4145
0.4324	0.4100	0.4387	0.4122	0.4451	0.4145	0.4514	0.4168
0.4365	0.4189	0.4430	0.4212	0.4496	0.4236	0.4562	0.4260
G12		G22		G32		G42	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4261	0.4077	0.4324	0.4100	0.4387	0.4122	0.4451	0.4145
0.4223	0.3990	0.4284	0.4011	0.4345	0.4033	0.4406	0.4055
0.4284	0.4011	0.4345	0.4033	0.4406	0.4055	0.4468	0.4077
0.4324	0.4100	0.4387	0.4122	0.4451	0.4145	0.4515	0.4168
G13		G23		G33		G43	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4223	0.3990	0.4284	0.4011	0.4345	0.4033	0.4406	0.4055
0.4185	0.3902	0.4243	0.3922	0.4302	0.3943	0.4361	0.3964
0.4243	0.3922	0.4302	0.3943	0.4361	0.3964	0.4420	0.3985
0.4284	0.4011	0.4345	0.4033	0.4406	0.4055	0.4468	0.4077
G14		G24		G34		G44	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4243	0.3922	0.4302	0.3943	0.4302	0.3943	0.4361	0.3964
0.4203	0.3834	0.4259	0.3853	0.4259	0.3853	0.4316	0.3873
0.4147	0.3814	0.4203	0.3834	0.4316	0.3873	0.4373	0.3893
0.4185	0.3902	0.4243	0.3922	0.4361	0.3964	0.4420	0.3985

Color Bin Structure

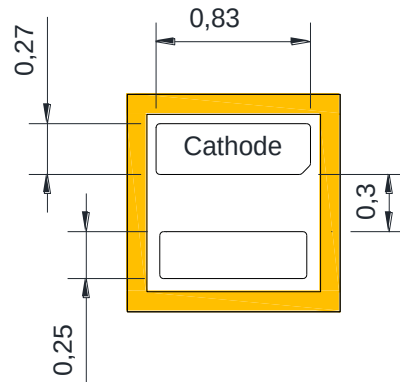
CIE Chromaticity Diagram (Warm White), $T_j=85^{\circ}\text{C}$


H11		H21		H31		H41	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4562	0.4260	0.4625	0.4275	0.4687	0.4289	0.4750	0.4304
0.4515	0.4168	0.4575	0.4182	0.4636	0.4197	0.4697	0.4211
0.4575	0.4182	0.4636	0.4197	0.4697	0.4211	0.4758	0.4225
0.4625	0.4275	0.4687	0.4289	0.4750	0.4304	0.4810	0.4319
H12		H22		H32		H42	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4515	0.4168	0.4575	0.4182	0.4636	0.4197	0.4697	0.4211
0.4468	0.4077	0.4526	0.4090	0.4585	0.4104	0.4644	0.4118
0.4526	0.4090	0.4585	0.4104	0.4644	0.4118	0.4703	0.4132
0.4575	0.4182	0.4636	0.4197	0.4697	0.4211	0.4758	0.4225
H13		H23		H33		H43	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4468	0.4077	0.4526	0.4090	0.4585	0.4104	0.4644	0.4118
0.4420	0.3985	0.4477	0.3998	0.4534	0.4012	0.4591	0.4025
0.4477	0.3998	0.4534	0.4012	0.4591	0.4025	0.4648	0.4038
0.4526	0.4090	0.4585	0.4104	0.4644	0.4118	0.4703	0.4132
H14		H24		H34		H44	
CIE x	CIE y	CIE x	CIE y	CIE x	CIE y	CIE x	CIE y
0.4420	0.3985	0.4477	0.3998	0.4534	0.4012	0.4591	0.4025
0.4373	0.3893	0.4428	0.3906	0.4483	0.3919	0.4538	0.3932
0.4428	0.3906	0.4483	0.3919	0.4538	0.3932	0.4593	0.3944
0.4477	0.3998	0.4534	0.4012	0.4591	0.4025	0.4648	0.4038

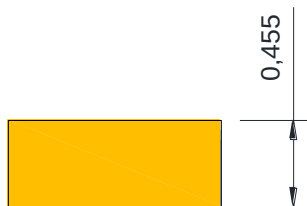
Mechanical Dimensions



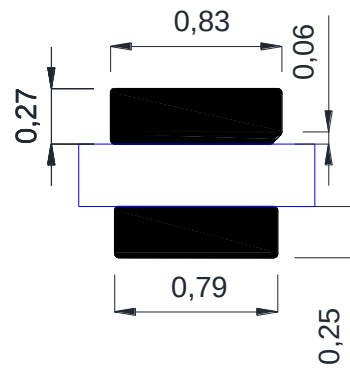
< Top >



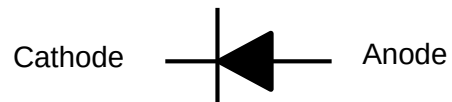
< Bottom >



< Side >



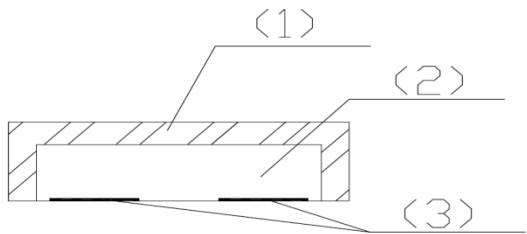
< Recommended Solder Pattern >



< Inner circuit >

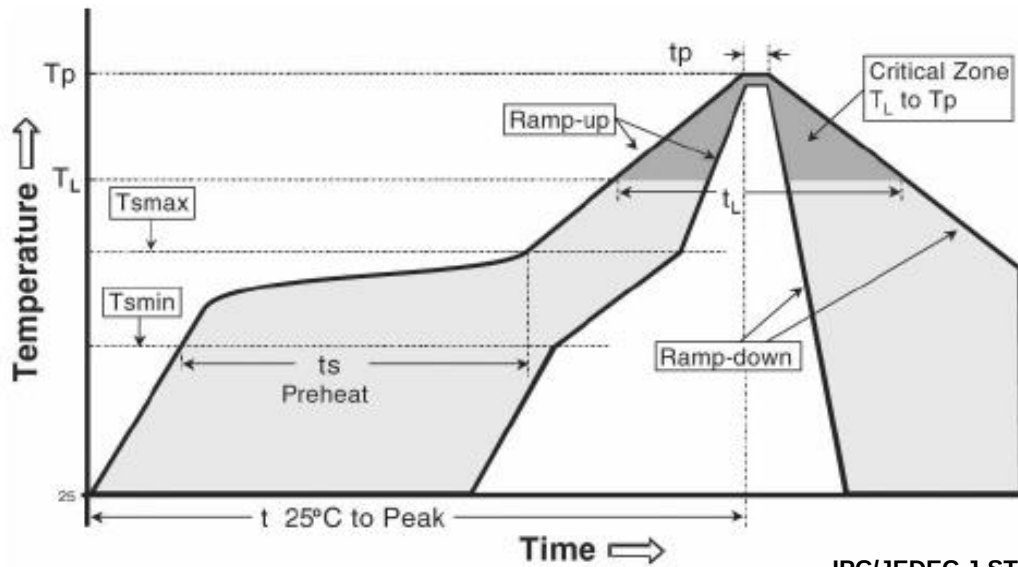
- (1) All dimensions are in millimeters.
- (2) Scale : none
- (3) Undefined tolerance is $\pm 0.2\text{mm}$

Material Structure



No.	List	Material
①	Encapsulation	Silicone, Phosphor
②	Chip Source	GaN ON SAPPHIRE
③	Solder-PAD	Metal (Au)

Reflow Soldering Characteristics



IPC/JEDEC J-STD-020

Profile Feature	Pb-Free Assembly
Average ramp-up rate (T _{smax} to T _p)	3° C/second max.
Preheat - Temperature Min (T_{smin}) - Temperature Max (T_{smax}) - Time (T_{smin} to T_{smax}) (ts)	150 °C 180 °C 80-120 seconds
Time maintained above: - Temperature (T_L) - Time (t_L)	217~220°C 80-100 seconds
Peak Temperature (T _p)	250~255°C
Time within 5°C of actual Peak Temperature (tp)2	20-40 seconds
Ramp-down Rate	6 °C/second max.
Time 25°C to Peak Temperature	8 minutes max.
Atmosphere	Nitrogen (O ₂ <1000ppm)

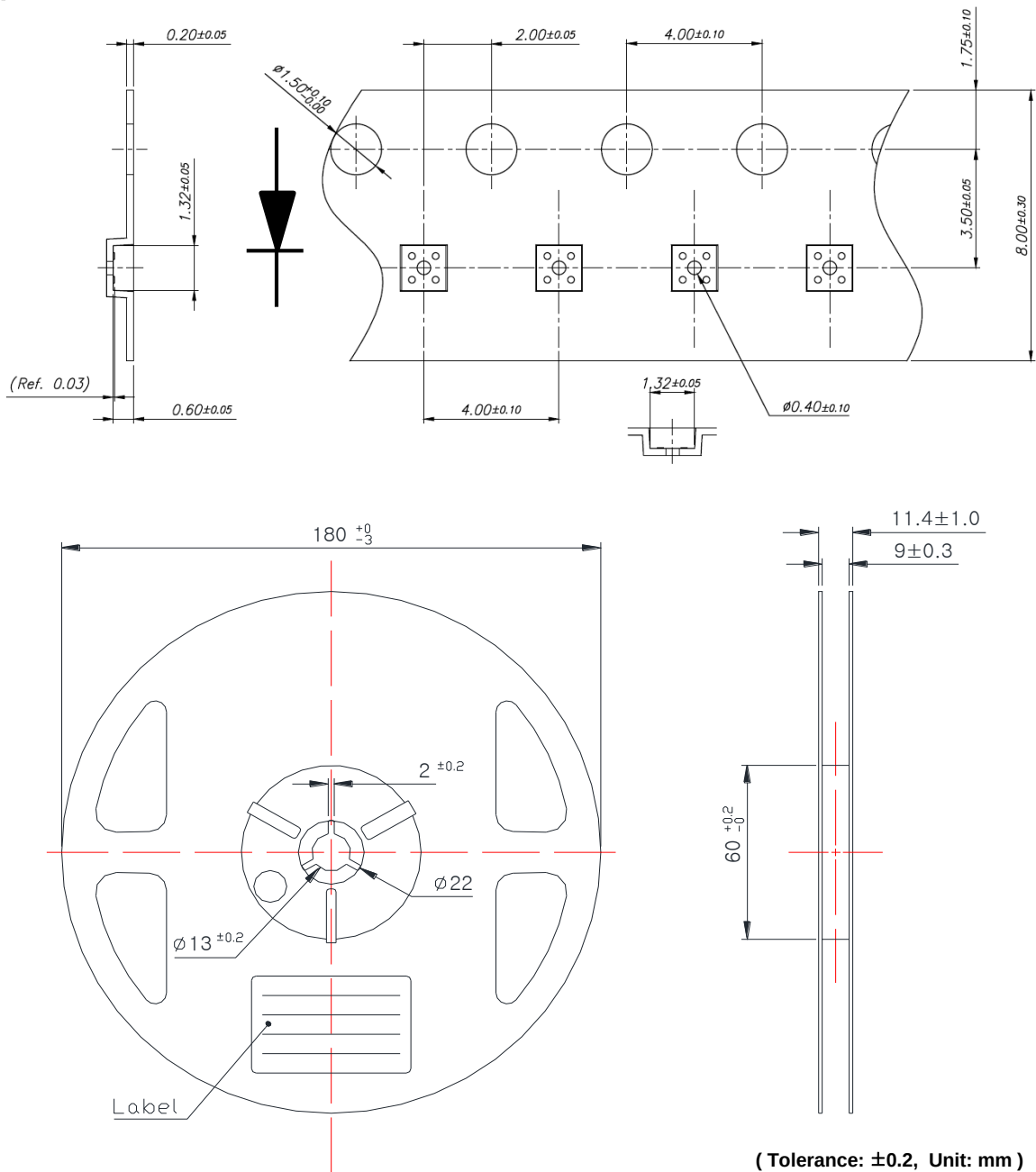
Caution

- (1) Reflow soldering is recommended not to be done more than two times. When 24 hours passed after first soldering, following reflow soldering will make LEDs damaged.
- (2) Re-soldering should not be done after the LEDs have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked on before and after such repair.
- (3) Do not put stress on the LEDs during heating.
- (4) After reflow, do not clean PCB with either water or solvent.

SMT recommendation

- (1) After reflow, Over 80% reflectance of PSR is recommended.
- (2) Solder paste materials (SAC 305, No Cleaning Paste)
- (3) We recommend TOV(Turn on Voltage) Test.
 - 1.8~2.8V at 1uA (per LED) for SZ8-Y11-XX-XX-A.
 - 4.2~5.6V at 1uA (per LED) for SZ8-Y11-XX-XX-B.
 - 6.6~8.5V at 30uA (per LED) for SZ8-Y11-XX-XX-C
- (4) We recommend IR Test 0~1uA at -5V (per LED) for SZ8-Y11-XX-XX-A.

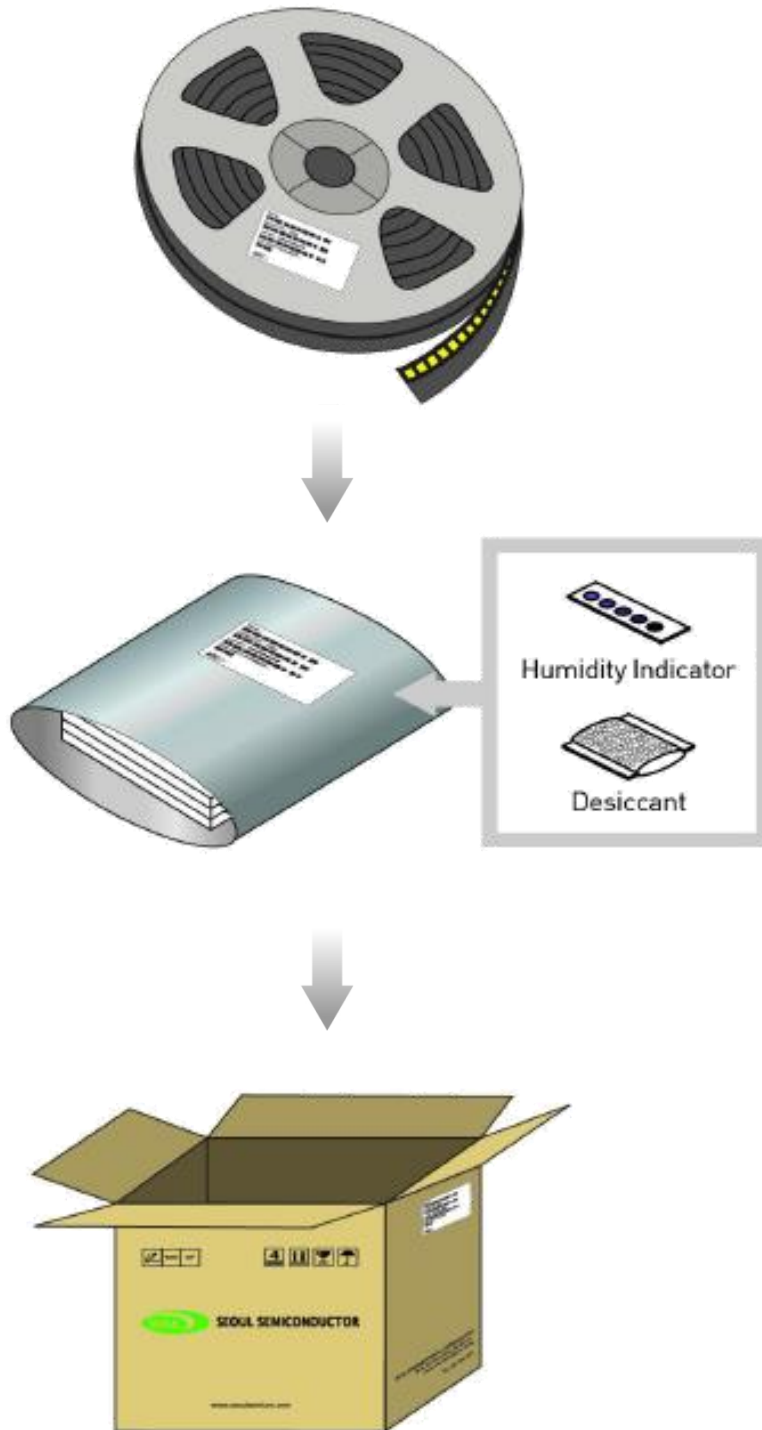
Emitter Tape & Reel Packaging



Notes :

- (1) Quantity : 3,000pcs/Reel
(empty slot possible in taping reel)
- (2) Cumulative Tolerance : Cumulative Tolerance/10 pitches to be $\pm 0.2\text{mm}$
- (3) Adhesion Strength of Cover Tape : Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at the angle of 10° to the carrier tape
- (4) Package : P/N, Manufacturing data Code No. and quantity to be indicated on a damp proof Package

Packaging Information



Handling of Silicone Resin for LEDs

- (1) During processing, mechanical stress on the surface should be minimized as much as possible. Sharp objects of all types should not be used to pierce the sealing compound.



- (2) Do not use tweezers to pick up or handle WICOP2 LEDs. A vacuum pick up should only be used.
- (3) When populating boards in SMT production, there are basically no restrictions regarding the form of the pick and place nozzle, except that mechanical pressure on the surface of the resin must be prevented. This is assured by choosing a pick and place nozzle which is smaller than the LED's area.
- (4) Silicone differs from materials conventionally used for the manufacturing of LEDs. These conditions must be considered during the handling of such devices. Compared to standard encapsulants, silicone is generally softer, and the surface is more likely to attract dust. As mentioned previously, the increased sensitivity to dust requires special care during processing.
- (5) Please do not mold this product into another resin (epoxy, urethane, etc) and do not handle this product with acid or sulfur material in sealed space.
- (6) Avoid leaving fingerprints on silicone resin parts.

Precaution for Use

(1) Storage

To avoid the moisture penetration, we recommend storing LED in a dry box with a desiccant. The recommended storage temperature range is 5°C to 30°C and a maximum humidity of RH50%.

(2) Use Precaution after Opening the Packaging

Use SMT techniques properly when you solder the LED as separation of the lens may affect the light output efficiency.

Pay attention to the following:

a. Recommend conditions after opening the package

- Sealing / Temperature : 5 ~ 30°C Humidity : less than RH60%

b. If the package has been opened more than 1 year (MSL 2) or the color of the desiccant changes, components should be dried for 10-24hr at 65±5°C

(3) Do not apply mechanical force or excess vibration during the cooling process to normal temperature after soldering.

(4) Do not rapidly cool device after soldering.

(5) Components should not be mounted on warped (non coplanar) portion of PCB.

(6) Radioactive exposure is not considered for the products listed here in.

(7) Gallium arsenide is used in some of the products listed in this publication. These products are dangerous if they are burned or shredded in the process of disposal. It is also dangerous to drink the liquid or inhale the gas generated by such products when chemically disposed of.

(8) This device should not be used in any type of fluid such as water, oil, organic solvent and etc.

(9) When the LED are in operation the maximum current should be decided after measuring the package temperature.

(10) The appearance and specifications of the product may be modified for improvement without notice.

(11) Long time exposure of sunlight or occasional UV exposure will cause lens discoloration.

Precaution for Use

(12) VOCs (Volatile organic compounds) emitted from materials used in the construction of fixtures can penetrate silicone encapsulants of LEDs and discolor when exposed to heat and photonic energy. The result can be a significant loss of light output from the fixture. Knowledge of the properties of the materials selected to be used in the construction of fixtures can help prevent these issues.

(13) The slug is electrically isolated.

(14) Attaching LEDs, do not use adhesives that outgas organic vapor.

(15) The driving circuit must be designed to allow forward voltage only when it is ON or OFF. If the reverse voltage is applied to LED, migration can be generated resulting in LED damage.

(16) LEDs are sensitive to Electro-Static Discharge (ESD) and Electrical Over Stress (EOS). Below is a list of suggestions that Seoul Semiconductor purposes to minimize these effects.

a. ESD (Electro Static Discharge)

Electrostatic discharge (ESD) is defined as the release of static electricity when two objects come into contact. While most ESD events are considered harmless, it can be an expensive problem in many industrial environments during production and storage. The damage from ESD to LEDs may cause the product to demonstrate unusual characteristics such as:

- Increase in reverse leakage current lowered turn-on voltage
- Abnormal emissions from the LED at low current

The following recommendations are suggested to help minimize the potential for an ESD event. One or more recommended work area suggestions:

- Ionizing fan setup
- ESD table/shelf mat made of conductive materials
- ESD safe storage containers

One or more personnel suggestion options:

- Antistatic wrist-strap
- Antistatic material shoes
- Antistatic clothes

Environmental controls:

- Humidity control (ESD gets worse in a dry environment)

Precaution for Use

b. EOS (Electrical Over Stress)

Electrical Over-Stress (EOS) is defined as damage that may occur when an electronic device is subjected to a current or voltage that is beyond the maximum specification limits of the device.

The effects from an EOS event can be noticed through product performance like:

- Changes to the performance of the LED package
(If the damage is around the bond pad area and since the package is completely encapsulated the package may turn on but flicker show severe performance degradation.)
- Changes to the light output of the luminaire from component failure
- Components on the board not operating at determined drive power

Failure of performance from entire fixture due to changes in circuit voltage and current across total circuit causing trickle down failures. It is impossible to predict the failure mode of every LED exposed to electrical overstress as the failure modes have been investigated to vary, but there are some common signs that will indicate an EOS event has occurred:

- This damage usually appears due to the thermal stress produced during the EOS event.

c. To help minimize the damage from an EOS event Seoul Semiconductor recommends utilizing:

- A surge protection circuit
- An appropriately rated over voltage protection device
- A current limiting device



Company Information

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Company Information

Seoul Semiconductor (www.SeoulSemicon.com) manufactures and packages a wide selection of light emitting diodes (LEDs) for the automotive, general illumination/lighting, Home appliance, signage and back lighting markets. The company is the world's fifth largest LED supplier, holding more than 10,000 patents globally, while offering a wide range of LED technology and production capacity in areas such as "nPola", "Acrich", the world's first commercially produced AC LED, and "Acrich MJT - Multi-Junction Technology" a proprietary family of high-voltage LEDs.

The company's broad product portfolio includes a wide array of package and device choices such as Acrich and Acirch2, high-brightness LEDs, mid-power LEDs, side-view LEDs, and through-hole type LEDs as well as custom modules, displays, and sensors.

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